

<b>Search Notes</b>  <b>*1052915</b>  <b>4*</b>	<b>Application/Control No.</b>  10529154	<b>Applicant(s)/Patent Under Reexamination</b>  UMENO, YOSHIHISA
	<b>Examiner</b>  Filip Zec	<b>Art Unit</b>  3785

SEARCHED			
Class	Subclass	Date	Examiner
62	180, 186, 256, 278, 336, 407	4/25/07	JJC
415	211.2	4/25/07	JJC
416	169A	4/25/07	JJC
219	400	4/25/07	JJC
62	419	6/15/09	FZ
62	407	5/4/10	FZ
		(updated 8/10/2010)	FZ
62	419,426	12/12/2010	FZ

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted SPE George Nguyen	4/26/07	JJC
Consulted primary William Doerller	4/26/07 (updated 6/15/09)	JJC
Consulted primary examiner Richard Edgar	4/26/07	JJC
Updated search in East	4/27/08	JJC
Updated EAST search	12/31/08	JJC
Updated EAST search	6/15/09	FZ
	(updated 5/4/10)	FZ
	(updated 8/10/2010)	FZ
	(updated 12/12/2010)	FZ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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